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Application/Control No.

PATRICK A. DARNO 2163

U.S. PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-5,740,425 04-1998 Povilus, David S. 707/100 US-2003/0130905 A1 07-2003 Foster et al. 705/26 В US-2003/0097211 A1 05-2003 Carroll et al. 701/33 C US-6.182.275 B1 01-2001 Beelitz et al. 717/175 n US-Е US-G USн US-US-US-J US-

## FOREIGN PATENT DOCUMENTS

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